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Certified Reference Material

Certificate of Analysis

Product ID: MBH-41X GLV15-19

Product Description: Galvanizing Alloy

ISO 17034:2016

ISO/IEC 17025:2017 9001:2015

Revision No.: 001 Revision Date: 03/30/2022

Description and Intended Use: This Certified Reference Material is covered under the scope of accreditation to ISO 17034 by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in ISO 17025 accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Certified Values listed in wt.% with associated uncertainties

Ag	0.0003 ± 0.0001	ΑI	2.49 ± 0.04	Bi	0.0004 ± 0.0002	Cu	0.0029 ± 0.0004
Fe	0.027 ± 0.002	Mg	1.05 ± 0.02	Mn	0.0015 ± 0.0002	Pb	0.0028 ± 0.0002
Si	0.0026 ± 0.0008	٧	0.00018 ± 0.00007				

Indicative Values listed in ppm

As (13)Sb (7) Zn (96.7%)

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where H=U_{nom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

1.
$$N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$
 2. $U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$

Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

- LGC Standards Manchester NH
- Dirats Laboratories Westfield, MA
- Connecticut Metallurgical, Inc. East Hartford, CT
- TCR Engineering Services Maharashtra, India
- NSL Analytical Services Cleveland, OH
- SGS MSi Melrose Park II
- AnchorCert Analytical Birmingham. UK
- EAG Laboratories Liverpool, NY
- Laboratory Testing, Inc. Hatfield, PA
- New Hampshire Materials Laboratory Somersworth, NH
- Scrooby's Laboratory Services Benoni, South Africa
- TEC Eurolab Campogalliano (MO), Italy
- Applied Technical Services Marietta, GA
- Lucid Laboratories Telangana, India
- Luvak Inc. Boylston, MA

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. This material is individually chill cast per piece. This manner of casting can cause the formation of inhomogeneous segregates in the upper, engraved portion of the disk. Therefore, the certification information above is not applicable to within 3mm of the engraved surface. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Kimberly Hadriotis, Global Product Manager

March 30, 2022 Certification Date



ISO 17034 Accredited: Reference Materials Producer, Certificate # 2848.02 ISO/IEC 17025 Accredited: Chemical Testing, Certificate # 2848.01



The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Ag	Al	As	Bi	Cu	Fe	Mg	Mn	Pb	Sb	Si	٧	Zn
1	0.0001	2.3580	0.0008	0.0001	0.0016	0.0218	0.9770	0.0010	0.0021	0.0001	0.0013	0.0001	96.300
2	0.0002	2.3950	0.0010	0.0001	0.0024	0.0224	0.9970	0.0010	0.0022	0.0005	0.0014	0.0001	96.450
3	0.0002	2.4100	0.0014	0.0003	0.0025	0.0230	1.0170	0.0010	0.0025	0.0008	0.0014	0.0001	96.490
4	0.0002	2.4676	0.0015	0.0003	0.0025	0.0245	1.0500	0.0010	0.0026	0.0010	0.0020	0.0001	96.800
5	0.0002	2.4700	0.0018	0.0004	0.0030	0.0252	1.0505	0.0013	0.0027	0.0013	0.0022	0.0002	97.500
6	0.0003	2.4900	<0.00005	0.0006	0.0030	0.0260	1.0530	0.0013	0.0028	<0.00005	0.0030	0.0003	
7	0.0004	2.4900	<0.0001	0.0007	0.0031	0.0271	1.0550	0.0013	0.0029	<0.0001	0.0030	0.0003	
8	0.0005	2.4900	<0.0001	<0.0002	0.0031	0.0276	1.0600	0.0014	0.0029	<0.001	0.0038	0.0003	
9	<0.0002	2.5000	< 0.0002	<0.0005	0.0031	0.0280	1.0600	0.0015	0.0030	<0.001	0.0040	<0.0001	
10	<0.0002	2.5010	<0.001	<0.0005	0.0031	0.0280	1.0600	0.0017	0.0030	<0.0010	0.0040	<0.0005	
11	<0.0005	2.5037	<0.001	<0.0005	0.0032	0.0288	1.0655	0.0017	0.0031	<0.002	< 0.002	<0.0005	
12	<0.001	2.5200	<0.002	<0.001	0.0033	0.0288	1.0700	0.0017	0.0032	<0.002	<0.002	<0.0005	
13	<0.001	2.5250	<0.002	<0.0010	0.0041	0.0290	1.0890	0.0019	<0.002	<0.002	< 0.003	<0.0005	
14	<0.0010	2.5380	<0.002	<0.002	<0.002	0.0300	1.1500	0.0019	< 0.002		< 0.0050	<0.001	
15		2.5407	<0.0050		<0.002	0.0301		0.0020	< 0.002		<0.01	<0.001	
16		2.5610	<0.01		<0.002	0.0310		0.0024				<0.0010	
17						0.0330		<0.0005					
Mean	0.0003	2.4850	0.0013	0.0004	0.0029	0.0273	1.0539	0.0015	0.0028	0.0007	0.0026	0.0002	96.708
STDV	0.0001	0.0553	0.0004	0.0002	0.0006	0.0031	0.0407	0.0004	0.0003	0.0005	0.0011	0.0001	0.4786
Certified	0.0003	2.49	(0.0013)	0.0004	0.0029	0.027	1.05	0.0015	0.0028	(0.0007)	0.0026	0.00018	(96.7)
U _{CRM}	0.0001	0.04		0.0002	0.0004	0.002	0.02	0.0002	0.0002		0.0008	0.00007	
Methods	I,IM,X	I,O,X	I,IM,O,X	I,IM,O,X	I,IM,O,X,A	I,IM,O,X		I,IM,O,X	I,IM,O,X,A	I,IM,O	I,IM,O,X,W	I,IM,O,X	I,O,X

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES